











#### SN54LVC373A, SN74LVC373A

SCAS295T-JANUARY 1993-REVISED JULY 2014

# SNx4LVC373A Octal Transparent D-Type Latches With 3-State Outputs

#### **Features**

- Operate From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 6.8 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)  $<0.8 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot) >2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V<sub>CC</sub>)
- I<sub>off</sub> Supports Live-Insertion, Partial-Power-Down Mode, and Back-Drive Protection
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- On Products Compliant to MIL-PRF-38535. All Parameters Are Tested Unless Otherwise Noted. On All Other Products, Production Processing Does Not Necessarily Include Testing of All Parameters.

#### 2 Applications

- **Network Switches**
- TV Set-top Boxes
- Motor Drives
- PCs and Notebooks

#### 3 Description

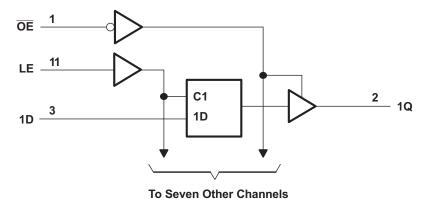
The SN54LVC373A octal transparent D-type latch is designed for 2.7-V to 3.6-V V<sub>CC</sub> operation, and the SN74LVC373A octal transparent D-type latch is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
	SSOP (20)	7.20 mm × 5.30 mm		
	SOIC (20)	12.80 mm × 7.50 mm		
SNx4LVC373A	PDIP (20)	24.33 mm 6.35 mm		
	TSSOP (20)	6.50 mm × 4.40 mm		
	VQFN (20)	4.50 mm × 3.50 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## Simplified Schematic



Pin numbers shown are for the DB, DGV, DW, FK, J, N, NS, PW, RGY, and W packages.



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## **5 Revision History**

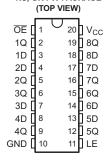
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision S (May 2005) to Revision T	Page
Updated document to new TI data sheet format	
Removed Ordering Information table.	1
Changed I <sub>off</sub> Feature	1
Added Military Disclaimer to Features	1
Added Applications	1
Added Handling Ratings table	4
Changed MAX ambient temperature from 85°C to 125°C.	5
Added Thermal Information table.	5
Added Typical Characteristics.	7
Added Detailed Description section	9

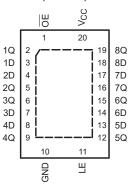


### 6 Pin Configuration and Functions

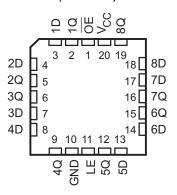
SN54LVC373A . . . J OR W PACKAGE SN74LVC373A . . . DB, DGV, DW, N, NS, OR PW PACKAGE



SN74LVC373A . . . RGY PACKAGE (TOP VIEW)



SN54LVC373A . . . FK PACKAGE (TOP VIEW)



#### **Pin Functions**

	PIN	1/0	DESCRIPTION
NO.	NAME	1/0	DESCRIPTION
1	ŌE	I	Enable Pin
2	1Q	0	Output 1
3	1D	I	Input 1
4	2D	I	Input 2
5	2Q	0	Output 2
6	3Q	0	Output 3
7	3D	I	Input 3
8	4D	I	Input 4
9	4Q	0	Output 4
10	GND	_	Ground Pin
11	LE	I	Latch Enable
12	5Q	0	Output 5
13	5D	I	Input 5
14	6D	I	Input 6
15	6Q	0	Output 6
16	7Q	0	Output 7
17	7D	I	Input 7
18	8D	I	Input 8
19	8Q	0	Output 8
20	VCC	-	Power Pin

GQN OR ZQN PACKAGE (TOP VIEW)

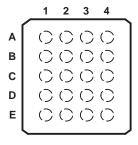


Table 1. Pin Assignments

	1	2	3	4
Α	1Q	ŌĒ	$V_{CC}$	8Q
В	2D	7D	1D	8D
С	3Q	2Q	6Q	7Q
D	4D	5D 3D		6D
E	GND	4Q	LE	5Q

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#### 7 Specifications

# 7.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range	upply voltage range			
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-impedance or power-off state (2)			6.5	V
Vo	Voltage range applied to any output in the hig	h or low state (2)(3)	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 Handling Ratings

			MIN	MAX	UNIT
T <sub>stg</sub>	Storage temperature rang	orage temperature range			
.,	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	0	2000	M
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	0	1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> The value of V<sub>CC</sub> is provided in the *Recommended Operating Conditions* table.



#### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN54LVC	373A	SN74LVC3	73A	
			MIN	MAX	MIN	MAX	UNIT
	Complete and	Operating	2	3.6	1.65	3.6	V
$V_{CC}$	Supply voltage	Data retention only	1.5		1.5		V
		V <sub>CC</sub> = 1.65 V to 1.95 V			0.65 × V <sub>CC</sub>		
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V			1.7		V
		V <sub>CC</sub> = 2.7 V to 3.6 V	2		2		
		V <sub>CC</sub> = 1.65 V to 1.95 V			0.	35 × V <sub>CC</sub>	
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V				0.7	V
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	V
V <sub>O</sub>	0	High or low state	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
	Output voltage	3-state	0	5.5	0	5.5	V
		V <sub>CC</sub> = 1.65 V				-4	
	I Pate Javas autorit autorit	V <sub>CC</sub> = 2.3 V				-8	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 2.7 V		-12		-12	mA
		V <sub>CC</sub> = 3 V		-24		7 0.35 × V <sub>CC</sub> 0.7 0.8 0 5.5 0 V <sub>CC</sub> 0 5.5 -4 -8 -12 -24 4 8 12 24 10	
		V <sub>CC</sub> = 1.65 V				4	
		V <sub>CC</sub> = 2.3 V				8	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12		12	mA
		V <sub>CC</sub> = 3 V		24		24	
Δt/Δν	Input transition rise or fall rate			10		10	ns/V
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	125	°C

<sup>(1)</sup> All unused inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, (SCBA004).

#### 7.4 Thermal Information

		SN74LVC373A	
	THERMAL METRIC <sup>(1)</sup>	PW	UNIT
		20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	102.5	
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	35.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	53.5	°C/W
ΨЈТ	Junction-to-top characterization parameter	2.2	C/VV
ΨЈВ	Junction-to-board characterization parameter	52.9	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

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#### 7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		V	SN54L	VC373A		SN74L	_VC373A		
PARAMETER			V <sub>CC</sub>	MIN	TYP <sup>(1)</sup>	MAX	MIN	TYP <sup>(1)</sup>	MAX	UNIT
	1. 100		1.65 V to 3.6 V				$V_{CC} - 0.2$			
	$I_{OH} = -100  \mu A$		2.7 V to 3.6 V	V <sub>CC</sub> - 0.2						
	I <sub>OH</sub> = -4 mA		1.65 V				1.2			
$V_{OH}$	$I_{OH} = -8 \text{ mA}$		2.3 V				1.7			V
	1 42 m A		2.7 V	2.2			2.2			
	$I_{OH} = -12 \text{ mA}$		3 V	2.4			2.4			
	I <sub>OH</sub> = -24 mA		3 V	2.2			2.2			
	I <sub>OL</sub> = 100 μA I <sub>OL</sub> = 4 mA		1.65 V to 3.6 V						0.2	V
			2.7 V to 3.6 V			0.2				
V			1.65 V						0.45	
$V_{OL}$	I <sub>OL</sub> = 8 mA		2.3 V						0.7	V
	I <sub>OL</sub> = 12 mA		2.7 V			0.4			0.4	
	I <sub>OL</sub> = 24 mA		3 V			0.55			0.55	
I <sub>I</sub>	V <sub>I</sub> = 0 to 5.5 V		3.6 V			±5			±5	μΑ
I <sub>off</sub>	$V_I$ or $V_O = 5.5 \text{ V}$		0						±10	μΑ
l <sub>OZ</sub>	$V_{O} = 0 \text{ to } 5.5 \text{ V}$		3.6 V			±15			±10	μΑ
	$V_I = V_{CC}$ or GND		2.6.1/			10			10	
I <sub>CC</sub>	$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{(2)}$	$I_{O} = 0$	3.6 V			10			10	μA
ΔI <sub>CC</sub>	One input at $V_{CC} - 0.6 \text{ V}$ Other inputs at $V_{CC}$ or GN	, ID	2.7 V to 3.6 V			500			500	μA
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND		3.3 V		4	12		4		pF
Co	$V_O = V_{CC}$ or GND		3.3 V		5.5	12		5.5		pF

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C. (2) This applies in the disabled state only.

#### 7.6 Timing Requirements, SN54LVC373A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

		SN54L		
PARAMETER		V <sub>CC</sub> = 2.7 V	V <sub>CC</sub> = 3.3 V ± 0.3 V	UNIT
		MIN MAX	MIN MAX	
t <sub>w</sub>	Pulse duration, LE high	3.3	3.3	ns
$t_{su}$	Setup time, data before LE↓	2	2	ns
t <sub>h</sub>	Hold time, data after LE↓	2	2	ns

#### 7.7 Timing Requirements, SN74LVC373A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

				SN74LVC373A						
PARAMETER		V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>w</sub>	Pulse duration, LE high	9		4		3.3		3.3		ns
t <sub>su</sub>	Setup time, data before LE↓	6		4		2		2		ns
t <sub>h</sub>	Hold time, data after LE↓	4		2		1.5		1.5		ns

Product Folder Links: SN54LVC373A SN74LVC373A



#### 7.8 Switching Characteristics, SN54LVC373A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN54L\			
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.7 V	V <sub>CC</sub> = 3 ± 0.3	UNIT	
			MIN MAX	MIN	MAX	
	D	0	8.5	1	7.5	20
t <sub>pd</sub>	LE	Q	9.5	1	8.5	ns
t <sub>en</sub>	ŌĒ	Q	8.7	1	7.7	ns
t <sub>dis</sub>	ŌĒ	Q	8	0.5	7	ns

#### 7.9 Switching Characteristics, SN74LVC373A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

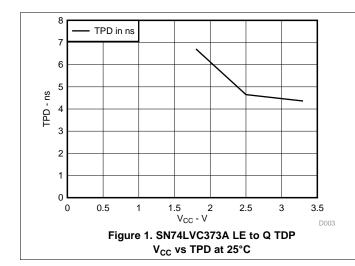
		TO (OUTPUT)	SN74LVC373A									
PARAMETER	FROM (INPUT)				V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
4	D	Q	1	19.1	1	9.6		7.8	1.5	6.8	no	
t <sub>pd</sub>	LE	Q	1	22.8	1	10.5		8.2	2	7.6	ns	
t <sub>en</sub>	ŌĒ	Q	1	20	1	10.5		8.7	1.5	7.7	ns	
t <sub>dis</sub>	ŌĒ	Q	1	19.3	1	7.8		7.6	1.5	7	ns	
t <sub>sk(o)</sub>				1		1		1		1	ns	

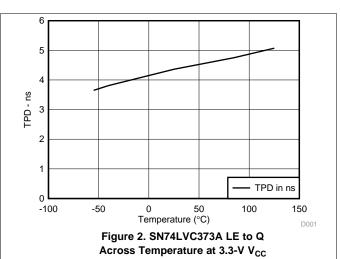
## 7.10 Operating Characteristics

 $T_A = 25$ °C

	PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT
	Power dissipation capacitance	Outputs enabled	f = 10 MHz	61	56	46	~F
Cpd	per latch	Outputs disabled	1 = 10 NIM2	3	3	3	pF

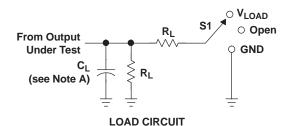
#### 7.11 Typical Characteristics





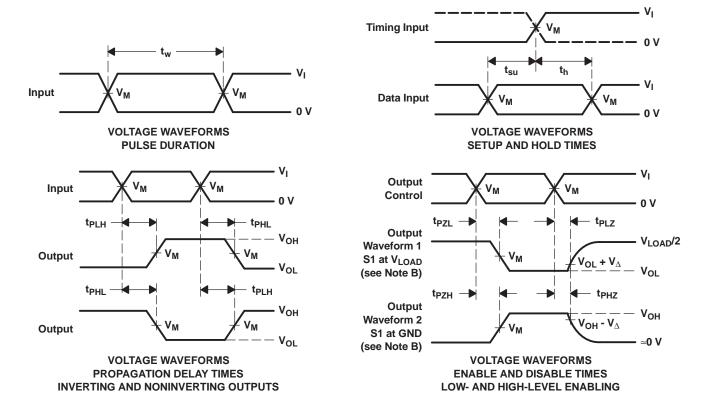


#### 8 Parameter Measurement Information



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	$V_{LOAD}$
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

V	INF	INPUTS		V	•		V
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$V_{\Delta}$
1.8 V ± 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤ <b>2</b> ns	V <sub>CC</sub> /2	2 × V <sub>CC</sub>	30 pF	<b>500</b> Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0 = 50~\Omega$ .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

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#### 9 Detailed Description

#### 9.1 Overview

While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels set up at the D inputs.

A buffered output-enable  $(\overline{OE})$  input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

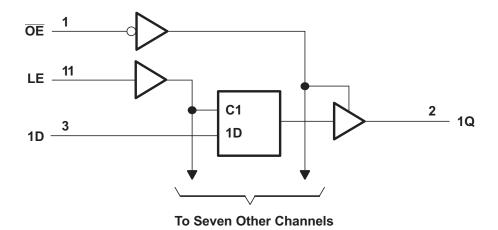
OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

These devices are fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

#### 9.2 Functional Block Diagram



Pin numbers shown are for the DB, DGV, DW, FK, J, N, NS, PW, RGY, and W packages.



#### 9.3 Feature Description

- · Wide operating voltage range
  - Operates from 1.65 V to 3.6 V
- Allows down voltage translation
  - Inputs accept voltages to 5.5 V
- I<sub>off</sub> feature
  - Allows voltages on the inputs and outputs when  $V_{CC}$  is 0 V

#### 9.4 Device Functional Modes

**Table 2. Function Table (Each Latch)** 

	INPUTS		OUTPUT
ŌĒ	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	X	$Q_0$
Н	Χ	X	Z

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#### 10 Application and Implementation

#### 10.1 Application Information

The SN74LVC373A is a high-drive CMOS device that can be used for a multitude of bus-interface type applications where the data needs to be retained or latched. It can produce 24 mA of drive current at 3.3 V. Therefore, this device is ideal for driving multiple outputs and for high speed applications up to 100 Mhz. The inputs are 5.5 V tolerant allowing it to translate down to  $V_{CC}$ .

#### 10.2 Typical Application

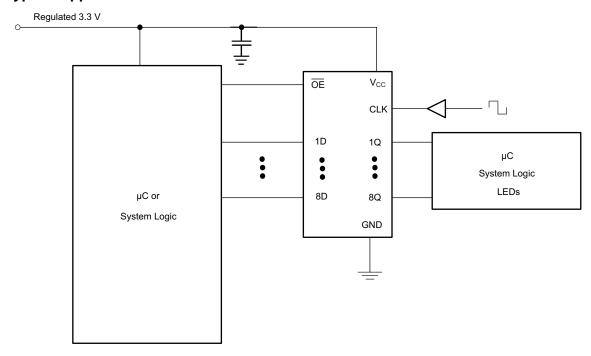


Figure 4. Typical Application Diagram

#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads; therefore, routing and load conditions should be considered to prevent ringing.

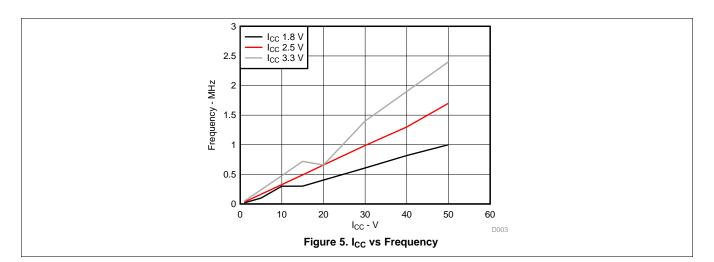
#### 10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
  - Rise time and fall time specs: See (Δt/ΔV) in the Recommended Operating Conditions table.
  - Specified high and low levels: See (V<sub>IH</sub> and V<sub>II</sub>) in the *Recommended Operating Conditions* table.
  - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V<sub>CC</sub>.
- 2. Recommend Output Conditions
  - Load currents should not exceed 50 mA per output and 100 mA total for the part.
  - Outputs should not be pulled above V<sub>CC</sub>.

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# Typical Application (continued) 10.2.3 Application Curves



## 11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each  $V_{CC}$  pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ f is recommended; if there are multiple  $V_{CC}$  pins, then 0.01  $\mu$ f or 0.022  $\mu$ f is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ f and a 1  $\mu$ f are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

#### 12 Layout

#### 12.1 Layout Guidelines

When using multiple bit logic devices inputs should never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Figure 6 specifies the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is generally acceptable to float outputs, unless the part is a transceiver.

#### 12.2 Layout Example

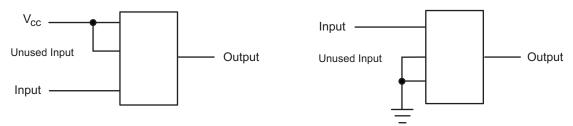


Figure 6. Layout Diagram



#### 13 Device and Documentation Support

#### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 3. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54LVC373A	Click here	Click here	Click here	Click here	Click here
SN74LVC373A	Click here	Click here	Click here	Click here	Click here

#### 13.2 Trademarks

All trademarks are the property of their respective owners.

#### 13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

#### 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN54LVC373A SN74LVC373A

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17-Mar-2017

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9757301Q2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9757301Q2A SNJ54LVC 373AFK	Samples
5962-9757301QRA	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757301QR A SNJ54LVC373AJ	Samples
5962-9757301QSA	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757301QS A SNJ54LVC373AW	Samples
SN74LVC373ADBR	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373ADBRE4	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373ADGVR	ACTIVE	TVSOP	DGV	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373ADW	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC373A	Samples
SN74LVC373ADWG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC373A	Samples
SN74LVC373ADWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC373A	Samples
SN74LVC373AN	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74LVC373AN	Samples
SN74LVC373ANSR	ACTIVE	so	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC373A	Samples
SN74LVC373ANSRG4	ACTIVE	SO	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC373A	Samples
SN74LVC373APW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373APWE4	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373APWG4	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples





17-Mar-2017

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LVC373APWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373APWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373APWT	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373APWTE4	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SN74LVC373ARGYR	ACTIVE	VQFN	RGY	20	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	LC373A	Samples
SN74LVC373AZQNR	ACTIVE	BGA MICROSTAR JUNIOR	ZQN	20	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	LC373A	Samples
SNJ54LVC373AFK	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 9757301Q2A SNJ54LVC 373AFK	Samples
SNJ54LVC373AJ	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757301QR A SNJ54LVC373AJ	Samples
SNJ54LVC373AW	ACTIVE	CFP	W	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9757301QS A SNJ54LVC373AW	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

#### PACKAGE OPTION ADDENDUM



17-Mar-2017

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54LVC373A, SN74LVC373A:

Catalog: SN74LVC373A

Automotive: SN74LVC373A-Q1, SN74LVC373A-Q1

Enhanced Product: SN74LVC373A-EP, SN74LVC373A-EP

Military: SN54LVC373A

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications



www.ti.com

## **PACKAGE OPTION ADDENDUM**

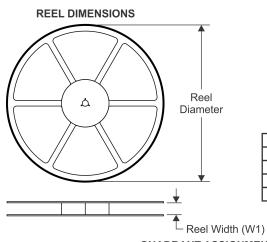
17-Mar-2017

• Military - QML certified for Military and Defense Applications

## PACKAGE MATERIALS INFORMATION

www.ti.com 6-May-2017

#### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS KO P1 BO W Cavity AO

	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

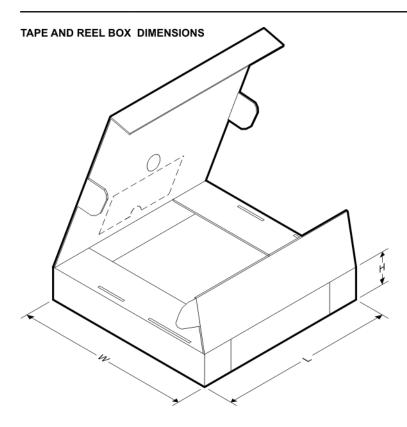
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC373ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LVC373ADGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC373ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74LVC373ANSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LVC373APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC373APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC373APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC373ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1
SN74LVC373AZQNR	BGA MI CROSTA R JUNI OR	ZQN	20	1000	330.0	12.4	3.3	4.3	1.6	8.0	12.0	Q1

www.ti.com 6-May-2017



\*All dimensions are nomina

All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC373ADBR	SSOP	DB	20	2000	367.0	367.0	38.0
SN74LVC373ADGVR	TVSOP	DGV	20	2000	367.0	367.0	35.0
SN74LVC373ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LVC373ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LVC373APWR	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LVC373APWR	TSSOP	PW	20	2000	367.0	367.0	38.0
SN74LVC373APWT	TSSOP	PW	20	250	367.0	367.0	38.0
SN74LVC373ARGYR	VQFN	RGY	20	3000	367.0	367.0	35.0
SN74LVC373AZQNR	BGA MICROSTAR JUNIOR	ZQN	20	1000	336.6	336.6	28.6

## FK (S-CQCC-N\*\*)

## LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



## RGY (R-PVQFN-N20)

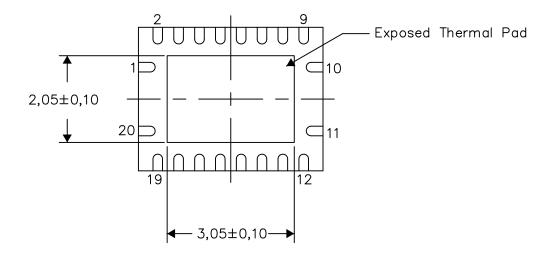
#### PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

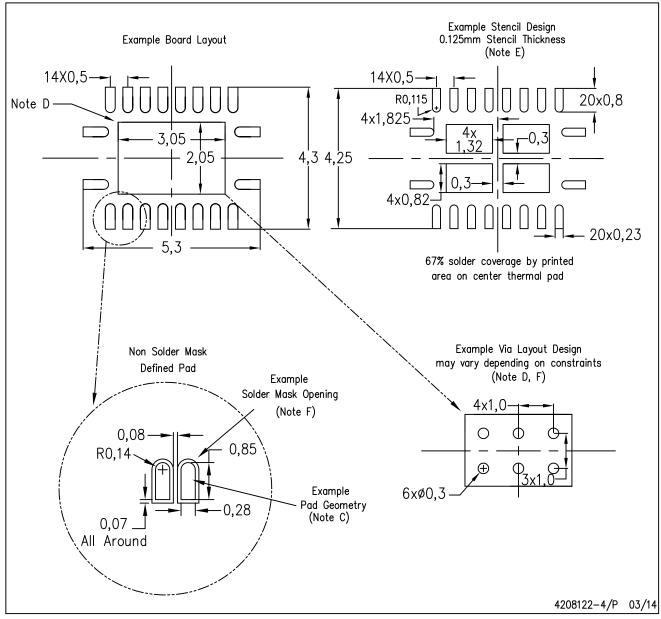
4206353-4/P 03/14

NOTE: All linear dimensions are in millimeters



# RGY (R-PVQFN-N20)

## PLASTIC QUAD FLATPACK NO-LEAD



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



#### **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

#### DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194 PW (R-PDSO-G20)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G20)

## PLASTIC SMALL OUTLINE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### DB (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

## N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# W (R-GDFP-F20)

## CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

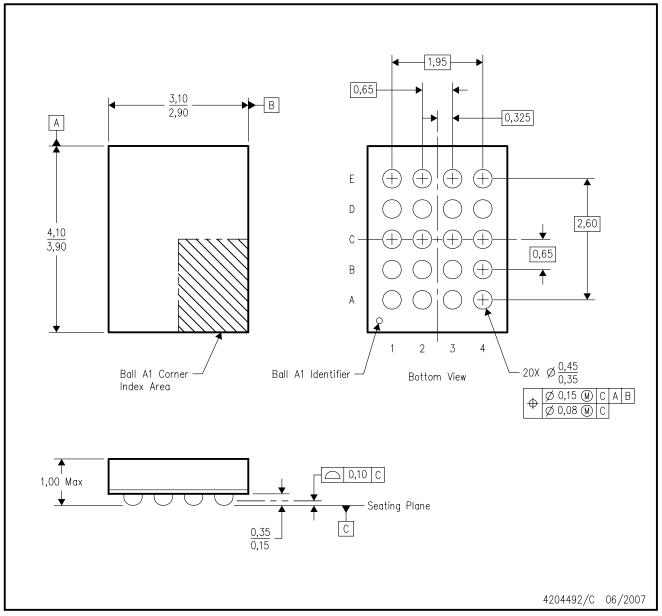
  D. Index point is provided on cap for terminal identification only.

  E. Falls within Mil—Std 1835 GDFP2—F20



# ZQN (R-PBGA-N20)

## PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BC-2.
- D. This package is lead-free. Refer to the 20 GQN package (drawing 4200704) for tin-lead (SnPb).



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